Trench Power MOSFET

-20 V, Single P-Channel, SOT-23

Features

- Leading –20 V Trench for Low R_{DS(on)}
- -1.8 V Rated for Low Voltage Gate Drive
- SOT-23 Surface Mount for Small Footprint
- NTRV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Load/Power Management for Portables
- Load/Power Management for Computing
- Charging Circuits and Battery Protection

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Parameter | | | Symbol | Value | Unit |
|---|-----------------|-----------------------|--------------------------------------|---------------|------|
| Drain-to-Source Voltage | | | V _{DSS} | -20 | V |
| Gate-to-Source Voltage | | | V _{GS} | ±8.0 | V |
| Continuous Drain | Steady | T _A = 25°C | I _D | -2.4 | Α |
| Current (Note 1) | State | T _A = 85°C | | -1.7 | |
| | t ≤ 10 s | T _A = 25°C | | -3.2 | |
| Power Dissipation (Note 1) | Steady State | T _A = 25°C | P _D | 0.73 | W |
| | t ≤ 10 s | | | 1.25 | |
| Continuous Drain | Steady | T _A = 25°C | I _D | -1.8 | Α |
| Current (Note 2) | State | T _A = 85°C | | -1.3 | |
| Power Dissipation (Note 2) | | T _A = 25°C | P _D | 0.42 | W |
| Pulsed Drain Current | tp = | : 10 μs | I _{DM} | -18 | Α |
| ESD Capability (Note 3) | | 100 pF, 1500 Ω | ESD | 225 | V |
| Operating Junction and Storage Temperature | | | T _J , T _{STG} | –55 to 150 | °C |
| Source Current (Body Dio | I _S | -2.4 | Α | | |
| Single Pulse Drain–to–Source Avalanche Energy (V_{GS} = -8 V, I_{L} = -1.8 Apk, L = 10 mH, R_{G} = 25 Ω) | | | EAS | 16 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | T _L | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

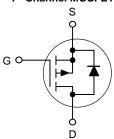


ON Semiconductor®

www.onsemi.com

| V _{(BR)DSS} | R _{DS(ON)} TYP | I _D MAX | |
|----------------------|-------------------------|--------------------|--|
| | 70 mΩ @ –4.5 V | | |
| –20 V | 90 mΩ @ –2.5 V | -3.2 A | |
| | 112 mΩ @ –1.8 V | | |

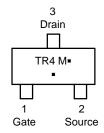
P-Channel MOSFET



MARKING DIAGRAM & PIN ASSIGNMENT



SOT-23 CASE 318 STYLE 21



TR4 = Device Code M = Date Code ■ Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|--------------|-----------|-----------------------|
| NTR4101PT1G | SOT-23 | 3000 / Tape & |
| NTRV4101PT1G | (Pb-Free) | Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Max | Unit |
|---|-----------------|-----|------|
| Junction-to-Ambient - Steady State (Note 1) | $R_{\theta JA}$ | 170 | °C/W |
| Junction-to-Ambient - t < 10 s (Note 1) | $R_{\theta JA}$ | 100 | |
| Junction-to-Ambient - Steady State (Note 2) | $R_{	heta JA}$ | 300 | |

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. ESD Rating Information: HBM Class 0

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

| Characteristic | | | Min | Тур | Max | Unit |
|---|---|---------------------|------|-----------------|------------------|------|
| OFF CHARACTERISTICS | | | | | | |
| Drain-to-Source Breakdown Voltage (Note 4) $(V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A})$ | | | -20 | | | V |
| Zero Gate Voltage Drain Current (Note 4) (V _{GS} = 0 V, V _{DS} = -16 V) | | | | | -1.0 | μΑ |
| Gate-to-Source Leakage Current (V _{GS} = ±8.0 V, V _{DS} = 0 V) | | | | | ±100 | nA |
| ON CHARACTERISTICS | | | | | | • |
| Gate Threshold Voltage (Note 4) $(V_{GS} = V_{DS}, I_D = -250 \mu A)$ | | V _{GS(th)} | -0.4 | -0.72 | -1.2 | V |
| Drain-to-Source On-Resistance $(V_{GS} = -4.5 \text{ V}, I_D = -1.6 \text{ A})$ $(V_{GS} = -2.5 \text{ V}, I_D = -1.3 \text{ A})$ $(V_{GS} = -1.8 \text{ V}, I_D = -0.9 \text{ A})$ | | | | 70 90 112 | 85 120 210 | mΩ |
| Forward Transconductance (V _{DS} = | g _{FS} | | 7.5 | | S | |
| CHARGES, CAPACITANCES & GA | TE RESISTANCE | | | | | |
| Input Capacitance | | C _{iss} | | 675 | | pF |
| Output Capacitance | $(V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}, V_{DS} = -10 \text{ V})$ | C _{oss} | | 100 | | - |
| Reverse Transfer Capacitance | | C _{rss} | | 75 | | |
| Total Gate Charge | $(V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$ | Q _{G(tot)} | | 7.5 | 8.5 | nC |
| Gate-to-Source Gate Charge | $(V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$ | Q_{GS} | | 1.2 | | nC |
| Gate-to-Drain "Miller" Charge | $(V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$ | Q_{GD} | | 2.2 | | nC |
| Gate Resistance | | R_{G} | | 6.5 | | Ω |
| SWITCHING CHARACTERISTICS | (Note 5) | | | | | |
| Turn-On Delay Time | | t _{d(on)} | | 7.5 | | ns |
| Rise Time | $(V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ | t _r | | 12.6 | | |
| Turn-Off Delay Time | $I_D = -1.6 \text{ A}, R_G = 6.0 \Omega$ | t _{d(off)} | | 30.2 | | |
| Fall Time | | t _f | | 21.0 | | |
| DRAIN-SOURCE DIODE CHARAC | TERISTICS | | | | | |
| Forward Diode Voltage | $(V_{GS} = 0 \text{ V}, I_{S} = -2.4 \text{ A})$ | V _{SD} | | -0.82 | -1.2 | V |
| Reverse Recovery Time | | t _{rr} | | 12.8 | 15 | ns |
| Charge Time | $(V_{GS} = 0 \text{ V},$ $dI_{SD}/dt = 100 \text{ A}/\mu\text{s}, I_{S} = -1.6 \text{ A})$ | ta | | 9.9 | | ns |
| Discharge Time |] | t _b | | 3.0 | | ns |
| Reverse Recovery Charge | Q _{rr} | | 1008 | | nC | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 4. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 5. Switching characteristics are independent of operating junction temperature.

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

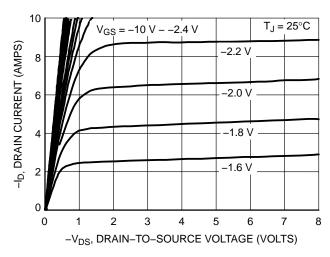


Figure 1. On-Region Characteristics

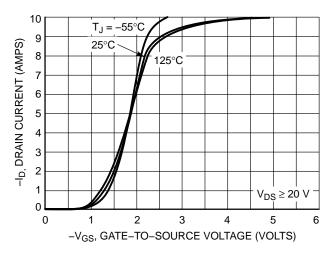


Figure 2. Transfer Characteristics

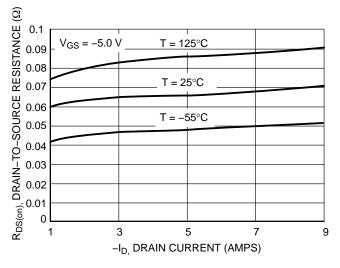


Figure 3. On–Resistance vs. Drain Current and Temperature

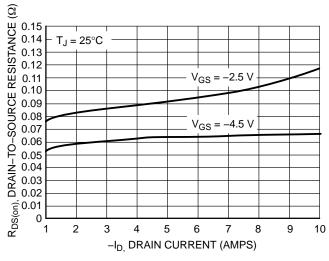


Figure 4. On–Resistance vs. Drain Current and Temperature

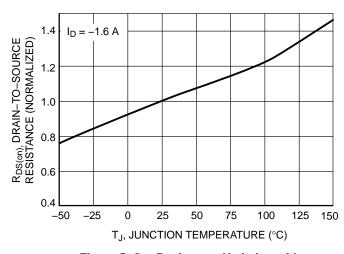


Figure 5. On–Resistance Variation with Temperature

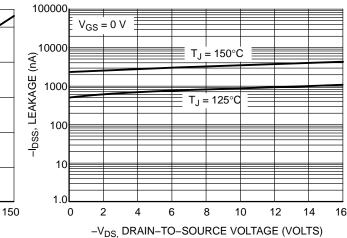


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES ($T_J = 25^{\circ}C$ unless otherwise noted)

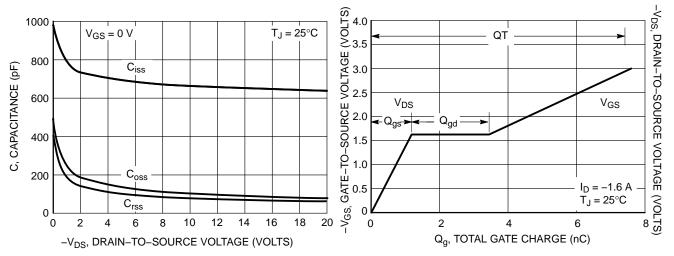


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Gate Charge

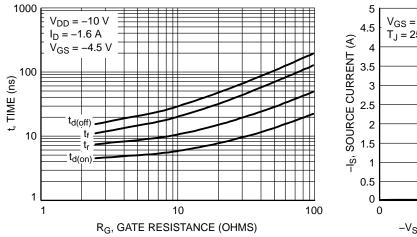


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

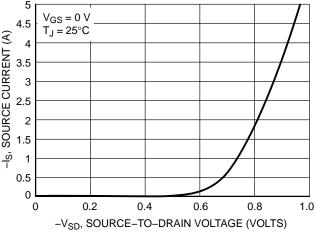


Figure 10. Diode Forward Voltage vs. Current

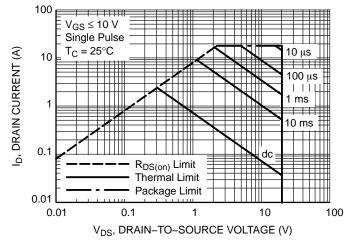
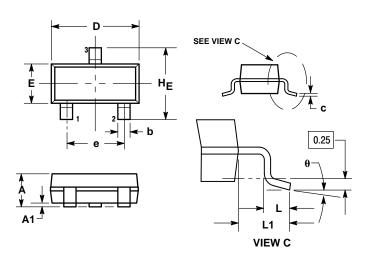


Figure 11. Maximum Rated Forward Biased Safe Operating Area

PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 **ISSUE AP**



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1. DII 1982.
- CONTROLLING DIMENSION: INCH.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,

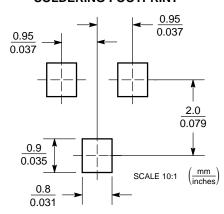
| PROT | TRUSIONS OR CATE BURRS. | | | | INCHES | | |
|------|-------------------------|------|------|-------|--------|-------|--|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX | |
| Α | 0.89 | 1.00 | 1.11 | 0.035 | 0.040 | 0.044 | |
| A1 | 0.01 | 0.06 | 0.10 | 0.001 | 0.002 | 0.004 | |
| b | 0.37 | 0.44 | 0.50 | 0.015 | 0.018 | 0.020 | |
| С | 0.09 | 0.13 | 0.18 | 0.003 | 0.005 | 0.007 | |
| D | 2.80 | 2.90 | 3.04 | 0.110 | 0.114 | 0.120 | |
| E | 1.20 | 1.30 | 1.40 | 0.047 | 0.051 | 0.055 | |
| е | 1.78 | 1.90 | 2.04 | 0.070 | 0.075 | 0.081 | |
| L | 0.10 | 0.20 | 0.30 | 0.004 | 0.008 | 0.012 | |
| L1 | 0.35 | 0.54 | 0.69 | 0.014 | 0.021 | 0.029 | |
| HE | 2.10 | 2.40 | 2.64 | 0.083 | 0.094 | 0.104 | |
| θ | 0° | | 10° | ٥° | | 10° | |

STYLE 12:

PIN 1. CATHODE 2. CATHODE

- 3. ANODE

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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